Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/684,018	MEYER, GARY		
Examiner	Art Unit		
Phi D. A	3637		

SEARCHED					
Class	Subclass	Date	Examiner		
52	127.5	2/4/2006	PA		
	127.7				
	127.8				
	127.9				
	122.1				
	125.1				
	126.1				
	126.5				
·	126.6				
	263				
	126.2				
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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SEARCH (INCLUDING SEAF		Y)
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Boswell Christopher 70/84, 208, 204 no cross	2/4/2006	
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